

MM54HC174/MM74HC174 Hex D Flip-Flops with Clear

General Description

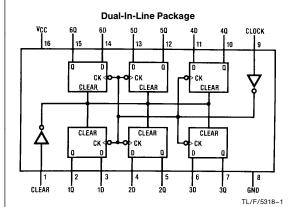
These edge triggered flip-flops utilize advanced silicon-gate CMOS technology to implement D-type flip-flops. They possess high noise immunity, low power, and speeds comparable to low power Schottky TTL circuits. This device contains 6 master-slave flip-flops with a common clock and common clear. Data on the D input having the specified setup and hold times is transferred to the Q output on the low to high transition of the CLOCK input. The CLEAR input when low, sets all outputs to a low state.

Each output can drive 10 low power Schottky TTL equivalent loads. The MM54HC174/MM74HC174 is functionally as well as pin compatible to the 54LS174/74LS174. All inputs are protected from damage due to static discharge by diodes to V_{CC} and ground.

Features

- Typical propagation delay: 16 ns
- Wide operating voltage range: 2-6V
- Low input current: 1 μ A maximum
- Low quiescent current: 80 µA (74HC Series)
- Output drive: 10 LSTTL loads

Connection and Logic Diagrams



Order Number MM54HC174 or MM74HC174

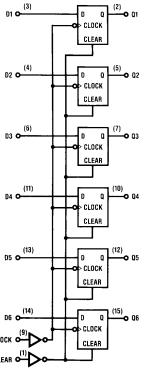
Truth Table

(Each Flip-Flop)

	Outputs		
Clear	Clock	D	Q
L	Х	Х	L
Н	↑	Н	Н
Н	↑	L	L
Н	Ĺ	Х	Q_0

- H = High level (steady state)
- L = Low level (steady state)
- X = Don't Care
- Transition from low to high level
- Q₀ = The level of Q before the indicated steady state

input conditions were established.



TL/F/5318-2

Absolute Maximum Ratings (Notes 1 & 2) If Military/Aerospace specified devices are required

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Supply Voltage (V _{CC})	-0.5 to $+7.0$ V
DC Input Voltage (V _{IN})	-1.5 to $V_{CC} + 1.5V$
DC Output Voltage (V _{OUT})	-0.5 to $V_{CC} + 0.5V$
Clamp Diode Current (I _{IK} , I _{OK})	\pm 20 mA
DC Output Current, per pin (IOUT)	\pm 25 mA
DC V _{CC} or GND Current, per pin (I _{CC})	\pm 50 mA
Storage Temperature Range (T _{STG})	-65°C to $+150^{\circ}\text{C}$

Power Dissipation (P_D)

(Note 3) 600 mW S.O. Package only 500 mW

Lead Temperature (T_L)

(Soldering 10 seconds) 260°C

Operating Conditions

Supply Voltage (V _{CC})	Min 2	Max 6	Units V
DC Input or Output Voltage (V_{IN}, V_{OUT})	0	V_{CC}	V
Operating Temp. Range (T _A) MM74HC MM54HC	-40 -55	+85 +125	°C
$ \begin{array}{ll} \text{Input Rise or Fall Times} \\ (t_{r},t_{f}) & V_{CC}\!=\!2.0V \\ & V_{CC}\!=\!4.5V \\ & V_{CC}\!=\!6.0V \end{array} $		1000 500 400	ns ns ns

DC Electrical Characteristics (Note 4)

Symbol	Parameter	Conditions	v _{cc}	T _A = 25°C		74HC T _A = -40 to 85°C	54HC T _A = -55 to 125°C	Units
				Тур		Guaranteed Limits		
V_{IH}	Minimum High Level Input Voltage		2.0V 4.5V 6.0V		1.5 3.15 4.2	1.5 3.15 4.2	1.5 3.15 4.2	V V V
V _{IL}	Maximum Low Level Input Voltage**		2.0V 4.5V 6.0V		0.5 1.35 1.8	0.5 1.35 1.8	0.5 1.35 1.8	V V V
V _{OH}	Minimum High Level Output Voltage	$V_{IN} = V_{IH} \text{ or } V_{IL}$ $ I_{OUT} \le 20 \mu A$	2.0V 4.5V 6.0V	2.0 4.5 6.0	1.9 4.4 5.9	1.9 4.4 5.9	1.9 4.4 5.9	V V V
		$V_{IN} = V_{IH} \text{ or } V_{IL}$ $ I_{OUT} \le 4.0 \text{ mA}$ $ I_{OUT} \le 5.2 \text{ mA}$	4.5V 6.0V	4.2 5.7	3.98 5.48	3.84 5.34	3.7 5.2	V V
V _{OL}	Maximum Low Level Output Voltage	$V_{IN} = V_{IH} \text{ or } V_{IL}$ $ I_{OUT} \le 20 \mu A$	2.0V 4.5V 6.0V	0 0 0	0.1 0.1 0.1	0.1 0.1 0.1	0.1 0.1 0.1	V V
		$V_{IN} = V_{IH} \text{ or } V_{IL}$ $ I_{OUT} \le 4.0 \text{ mA}$ $ I_{OUT} \le 5.2 \text{ mA}$	4.5V 6.0V	0.2 0.2	0.26 0.26	0.33 0.33	0.4 0.4	V
I _{IN}	Maximum Input Current	V _{IN} =V _{CC} or GND	6.0V		±0.1	±1.0	±1.0	μΑ
I _{CC}	Maximum Quiescent Supply Current	$V_{IN} = V_{CC}$ or GND $I_{OUT} = 0 \mu A$	6.0V		8.0	80	160	μΑ

Note 1: Absolute Maximum Ratings are those values beyond which damage to the device may occur.

Note 2: Unless otherwise specified all voltages are referenced to ground.

Note 3: Power Dissipation temperature derating — plastic "N" package: -12 mW/°C from 65°C to 85°C; ceramic "J" package: -12 mW/°C from 100°C to 125°C.

Note 4: For a power supply of 5V \pm 10% the worst case output voltages (V_{OH}, and V_{OL}) occur for HC at 4.5V. Thus the 4.5V values should be used when designing with this supply. Worst case V_{IH} and V_{IL} occur at V_{CC}=5.5V and 4.5V respectively. (The V_{IH} value at 5.5V is 3.85V.) The worst case leakage current (I_{IN}, I_{CC}, and I_{OZ}) occur for CMOS at the higher voltage and so the 6.0V values should be used.

^{**}V_{IL} limits are currently tested at 20% of V_{CC}. The above V_{IL} specification (30% of V_{CC}) will be implemented no later than Q1, CY'89.

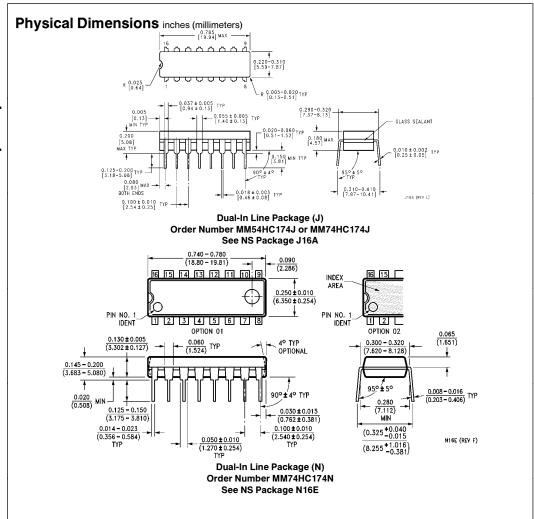
AC Electrical Characteristics $v_{CC}\!=\!5\text{V},\,T_{A}\!=\!25^{\circ}\text{C},\,C_{L}\!=\!15\,\text{pF},\,t_{r}\!=\!t_{f}\!=\!6\,\text{ns}$

Symbol	Parameter	Conditions	Тур	Guaranteed Limit	Units
f _{MAX}	Maximum Operating Frequency		50	30	MHz
t _{PHL} , t _{PLH}	Maximum Propagation Delay, Clock or Clear to Output		16	30	ns
t _{REM}	Minimum Removal Time, Clear to Clock		-2	5	ns
t _S	Minimum Setup Time Data to Clock		10	20	ns
t _H	Minimum Hold Time Clock to Data		0	5	ns
t _W	Minimum Pulse Width Clock or Clear		10	16	ns

AC Electrical Characteristics $C_L = 50 \text{ pF}, t_f = t_f = 6 \text{ ns}$ (unless otherwise specified)

Symbol	Parameter	Conditions	v _{cc}	T _A =	25°C	74HC T _A = -40 to 85°C	54HC T _A = -55 to 125°C	Units
				Тур		Guaranteed	Limits	
f _{MAX}	Maximum Operating Frequency		2.0V 4.5V 6.0V		5 27 31	4 21 24	3 18 20	MHz MHz MHz
t _{PHL} , t _{PLH}	Maximum Propagation Delay Clock or Clear to Output		2.0V 4.5V 6.0V	55 18 16	165 33 28	206 41 35	248 49 42	ns ns ns
t _{REM}	Minimum Removal Time Clear to Clock		2.0V 4.5V 6.0V	1 1 1	5 5 5	5 5 5	5 5 5	ns ns ns
ts	Minimum Setup Time Data to Clock		2.0V 4.5V 6.0V	42 12 10	100 20 17	125 25 21	150 30 25	ns ns ns
t _H	Minimum Hold Time Clock to Data		2.0V 4.5V 6.0V	1 1 1	5 5 5	5 5 5	5 5 5	ns ns ns
t _W	Minimum Pulse Width Clock or Clear		2.0V 4.5V 6.0V	35 10 8	80 16 14	106 20 18	120 24 20	ns ns ns
t _{TLH} , t _{THL}	Maximum Output Rise and Fall Time		2.0V 4.5V 6.0V	30 8 7	75 15 13	95 19 16	110 22 19	ns ns ns
t _r , t _f	Maximum Input Rise and Fall Time		2.0V 4.5V 6.0V		1000 500 400	1000 500 400	1000 500 400	ns ns ns
C _{PD}	Power Dissipation Capacitance (Note 5)	(per package)		136				pF
C _{IN}	Maximum Input Capacitance			5	10	10	10	pF

Note 5: C_{PD} determines the no load dynamic power consumption, $P_D = C_{PD} \ V_{CC}^2 \ f + I_{CC} \ V_{CC}$, and the no load dynamic current consumption, $I_S = C_{PD} \ V_{CC} \ f + I_{CC}$.



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